

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/601,005	KUDO, MAKOTO _	
Examiner	Art Unit	
Vincent Lai	2181	

	SEARCHED				
Class	Subclass	Date	Examiner		
712	205	12/5/2005	VL		
712	214	12/5/2005	VL		
712	200	12/5/2005	VL		

TAI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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(INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
Searched terms: fetch, instruction queue, branch, compar, loop count	12/5/2005	VL			